Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/749,929	LOOI ET AL.
Examiner	Art Unit
Raymond Phan	2111

	SEARCHED					
Class	Subclass	Date	Examiner			
710	300-315, 8-19, 260-269	12/5/2007	RP			

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
300,311	12/14/2007	RP			
312	12/14/2007	RP			
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